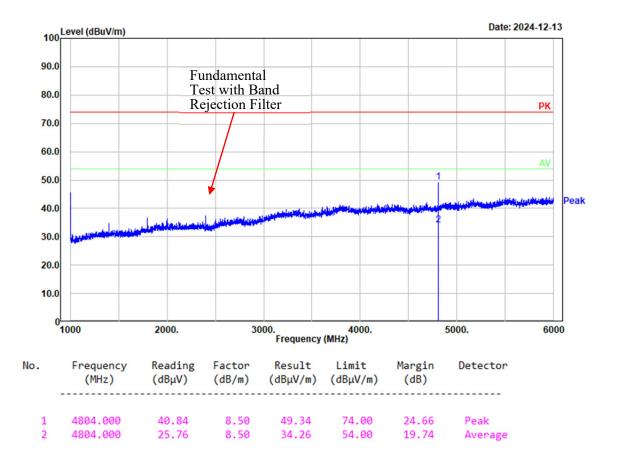
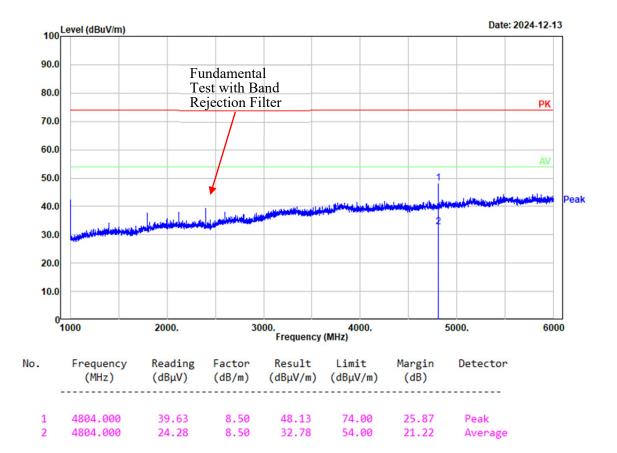
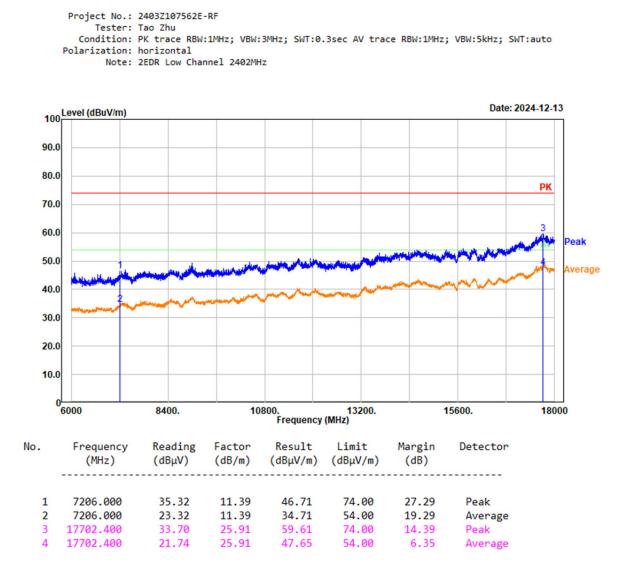
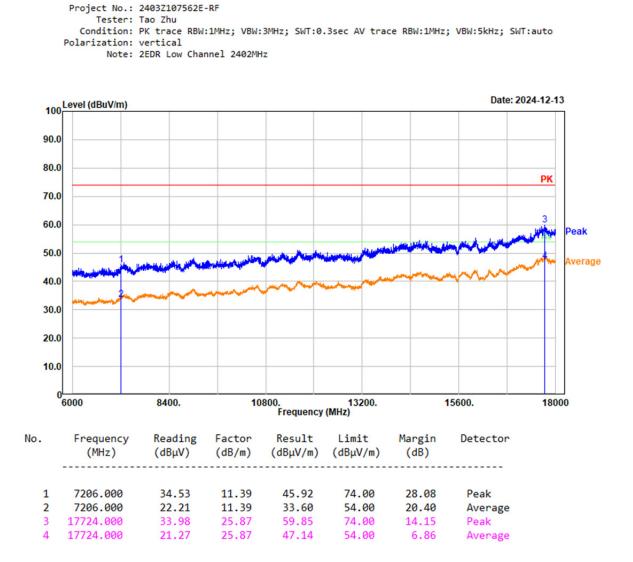
Project No.: 2403Z107562E-RF Tester: Tao Zhu Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec Polarization: horizontal Note: 2EDR Low Channel 2402MHz



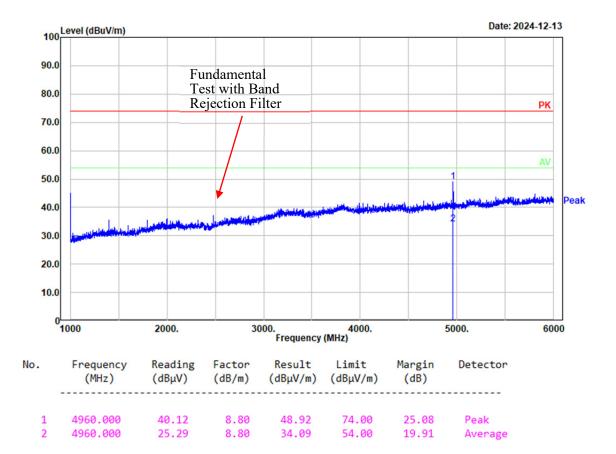
Project No.: 2403Z107562E-RF Tester: Tao Zhu Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec Polarization: vertical Note: 2EDR Low Channel 2402MHz



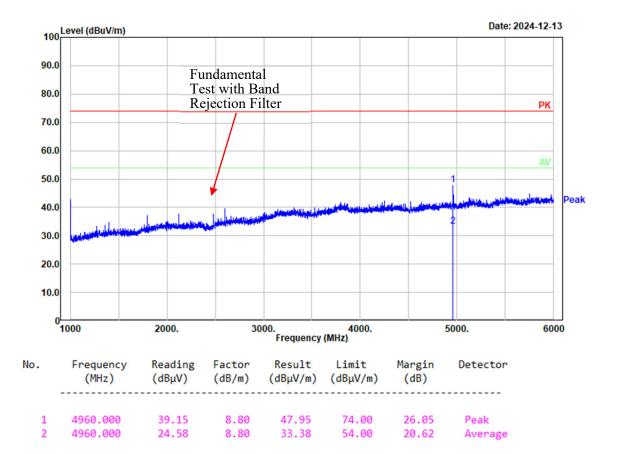


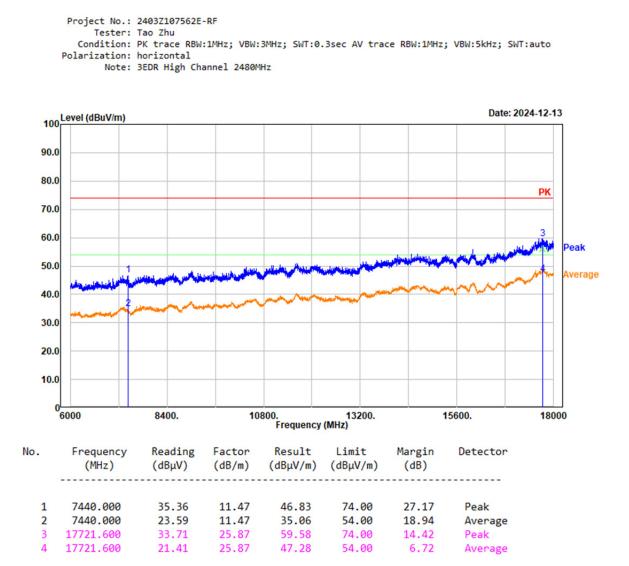


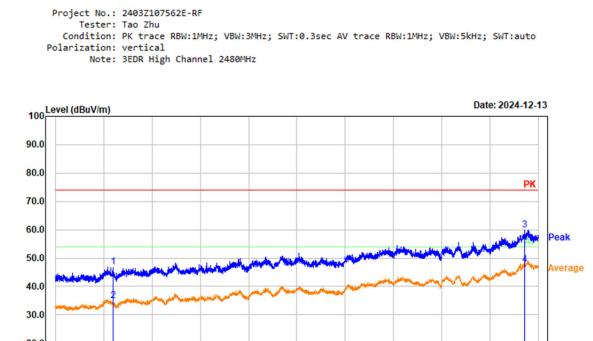
Project No.: 2403Z107562E-RF Tester: Tao Zhu Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec Polarization: horizontal Note: 3EDR High Channel 2480MHz

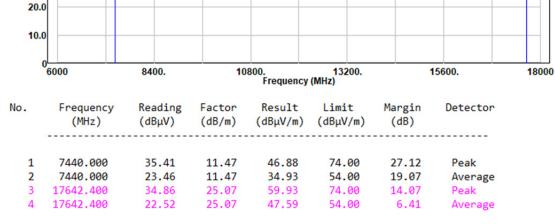


Project No.: 2403Z107562E-RF Tester: Tao Zhu Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec Polarization: vertical Note: 3EDR High Channel 2480MHz









4.3 RF Conducted Data

Please refer to Annex "2403Z107562E-RF-00B Appendix A" for detail test data.

5. EUT PHOTOGRAPHS

Please refer to the attachment 2403Z107562E-RF-EXP EUT EXTERNAL PHOTOGRAPHS and 2403Z107562E-RF-INP EUT INTERNAL PHOTOGRAPHS

6. TEST SETUP PHOTOGRAPHS

Please refer to the attachment 2403Z107562E-RF-00B-TSP TEST SETUP PHOTOGRAPHS.

===== END OF REPORT =====